

<b>Notice of References Cited</b>	Application/Control No. 10/608,591		Applicant(s)/Patent Under Reexamination SWEET ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,112,203 A	08-2000	Bharat et al.	707/5
	B	US-6,256,631 B1	07-2001	Malcolm, Jerry Walter	707/10
	C	US-6,336,112 B1	01-2002	Chakrabarti et al.	707/5
	D	US-6,411,952 B1	06-2002	Bharat et al.	707/5
	E	US-6,415,294 B1	07-2002	Niemi, Terho Reima Eerik	707/102
	F	US-6,446,065 B1	09-2002	Nishioka et al.	707/5
	G	US-6,601,075 B1	07-2003	Huang et al.	707/104.1
	H	US-6,633,868 B1	10-2003	Min et al.	707/3
	I	US-6,665,837 B1	12-2003	Dean et al.	715/501.1
	J	US-6,704,729 B1	03-2004	Klein et al.	707/5
	K	US-6,754,873 B1	06-2004	Law et al.	715/501.1
	L	US-6,871,202 B2	03-2005	Broder, Andrei Z.	707/7
	M	US-6,910,029 B1	06-2005	Sundaresan, Neelakantan	707/2

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,568,640 A	10-1996	Nishiyama et al.	707/1
	B	US-5,995,099 A	11-1999	Horstmann, Jens U.	715/501.1
	C	US-5,978,818 A	11-1999	Lin, Shaun	715/501.1
	D	US-6,189,019 B1	02-2001	Blumer et al.	715/513
	E	US-6,230,168 B1	05-2001	Unger et al.	715/501.1
	F	US-6,285,999 B1	09-2001	Page, Lawrence	707/5
	G	US-6,336,123 B1	01-2002	Inoue et al.	715/501.1
	H	US-6,560,600 B1	05-2003	Broder, Andrei Z.	707/7
	I	US-6,618,717 B1	09-2003	Karadimitriou et al.	706/61
	J	US-6,769,096 B1	07-2004	Kuppusamy et al.	715/530
	K	US-6,834,276 B1	12-2004	Jensen et al.	707/2
	L	US-6,877,002 B2	04-2005	Prince, John	707/5
	M	US-6,886,129 B1	04-2005	Raghavan et al.	715/501.1

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,634,062 A	05-1997	Shimizu et al.	715/501.1
	B	US-5,708,825 A	01-1998	Sotomayor, Bernardo Rafael	715/501.1
	C	US-5,794,257 A	08-1998	Liu et al.	715/501.1
	D	US-5,963,205 A	10-1999	Sotomayor, Bernardo	715/531
	E	US-6,035,330 A	03-2000	Astiz et al.	709/218
	F	US-6,189,002 B1	02-2001	Roitblat, Herbert L.	707/1
	G	US-2005/0091193 A1	04-2005	Frank et al.	707/001
	H	US-2005/0091209 A1	04-2005	Frank et al.	707/003
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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